Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/042,166	LIN ET AL.	
Examiner	Art Unit	
Hong Cho	2616	

SEARCHED			
Class	Subclass	Date	Examiner
370	443, 444, 449, 348	4/27/2006	нс
710	109-113	4/27/2006	нс
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
consulted Chau Nguyen for search help	4/26/2006	нс